Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/564,095	ANDOH ET AL.	
Examiner	Art Unit	
Joseph M. Pelham	3742	

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Class	Subclass	Date	Examiner
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INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
Above		3/2/2007	JP
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SEARCH N (INCLUDING SEARC		)
	DATE	EXMR
219/400,401 126/21a,20-20.1 99/474-476 See update history	3/2/2007	JP
Interference search printout	3/2/2007	JP